

Notice of References Cited

Application/Control No.

09/877,917

Applicant(s)/Patent Under
Reexamination
JAIN ET AL.

Examiner

Pablo N Tran

Art Unit

2685

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,597,923	07-2003	Vanghi et al.	455/522
	B	US-2002/0119796 A1	08-2002	Vanghi, Vieri	455/522
	C	US-6,278,882	08-2001	Choi, Yong Su	455/453
	D	US-6,404,826	06-2002	Schmidl et al.	375/340
	E	US-5,727,033	03-1998	Weaver et al.	375/358
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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